



ALPHA & OMEGA
SEMICONDUCTOR

AONA66916

100V N-Channel AlphaSGT™

General Description

- AlphaSGT™ N-Channel Power MOSFET
- Combination of Low $R_{DS(ON)}$ and wide safe operating area (SOA)
- Higher in-rush current enabled for faster start-up and shorter down time
- Pb-free lead plating, RoHS compliant, Halogen-free
- Top Side cooling for improved thermal performance

Applications

- Telecom
- Solar
- DC-DC

Product Summary

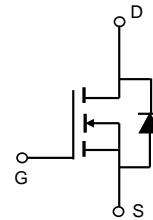
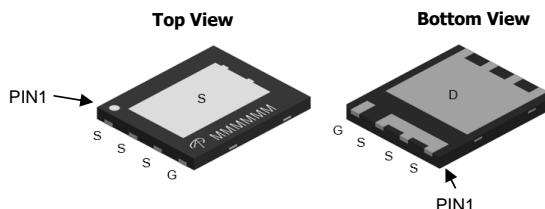
V_{DS}	100V
I_D (at $V_{GS}=10V$)	197A
$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 3.4mΩ
$R_{DS(ON)}$ (at $V_{GS}=6V$)	< 4.6mΩ

100% UIS Tested
100% R_g Tested

Max $T_j=175^\circ C$



DFN5X6



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AONA66916	DFN 5x6	Tape & Reel	5000

Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	197	A
$T_C=100^\circ C$	I_D	139	
Pulsed Drain Current ^C	I_{DM}	330	
Continuous Drain Current	I_{DSM}	30	A
$T_A=70^\circ C$	I_{DSM}	25	
Avalanche Current ^C	I_{AS}	60	A
Avalanche energy $L=0.1mH$ ^C	E_{AS}	180	mJ
Power Dissipation ^B	P_D	300	W
$T_C=100^\circ C$	P_D	150	
Power Dissipation ^A	P_{DSM}	7.5	W
$T_A=70^\circ C$	P_{DSM}	5.2	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	15	20	°C/W
Maximum Junction-to-Ambient ^D		40	50	°C/W
Maximum Junction-to-Case,bottom	Steady-State $R_{\theta JC}$	0.3	0.55	°C/W
Maximum Junction-to-Case,top	Steady-State $R_{\theta JC}$	0.25	0.5	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	100			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=100\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$		1	5	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$			±100	nA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.4	3	3.6	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=20\text{A}$ $T_J=125^\circ\text{C}$	2.8	3.4	6	$\text{m}\Omega$
		$V_{GS}=6\text{V}, I_D=20\text{A}$	5	3.7	4.6	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=20\text{A}$		75		S
V_{SD}	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$	0.7	1		V
I_S	Maximum Body-Diode Continuous Current				197	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=50\text{V}, f=1\text{MHz}$		5300		pF
C_{oss}	Output Capacitance			1500		pF
C_{rss}	Reverse Transfer Capacitance			26		pF
R_g	Gate resistance	$f=1\text{MHz}$	0.8	1.6	2.4	Ω
SWITCHING PARAMETERS						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=50\text{V}, I_D=20\text{A}$		66	95	nC
Q_{gs}	Gate Source Charge			18		nC
Q_{gd}	Gate Drain Charge			12		nC
Q_{oss}	Output Charge	$V_{GS}=0\text{V}, V_{DS}=50\text{V}$		123		nC
$t_{D(\text{on})}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=50\text{V}, R_L=2.5\Omega, R_{\text{GEN}}=3\Omega$		15		ns
t_r	Turn-On Rise Time			8		ns
$t_{D(\text{off})}$	Turn-Off Delay Time			46.5		ns
t_f	Turn-Off Fall Time			13		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$		43		ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$		280		nC

A. The value of R_{JJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on $R_{JJA} \leq 10\text{s}$ and the maximum allowed junction temperature of 175°C . The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation P_0 is based on $T_{J(\text{MAX})}=175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}=175^\circ\text{C}$.

D. The R_{JJA} is the sum of the thermal impedance from junction to case R_{JJC} and case to ambient.

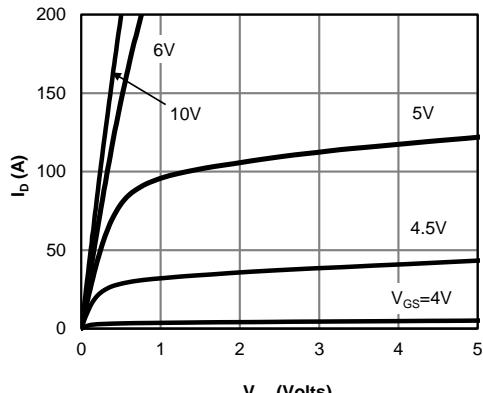
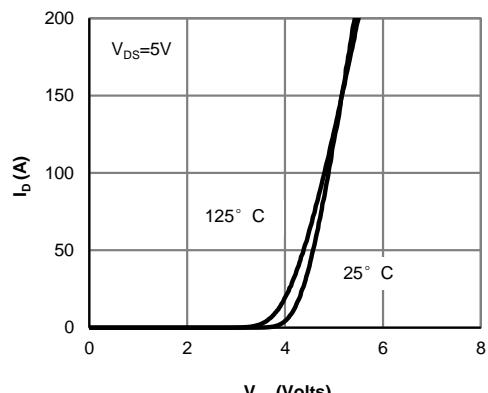
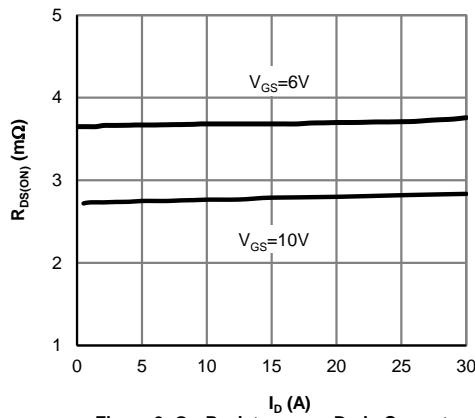
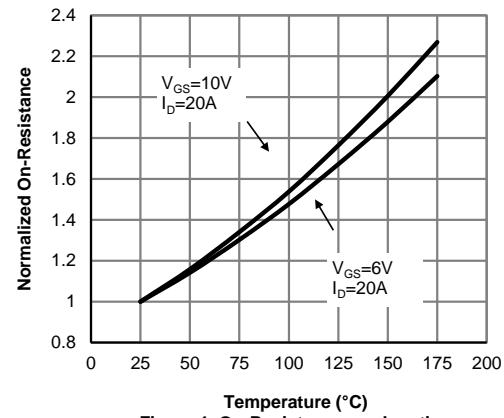
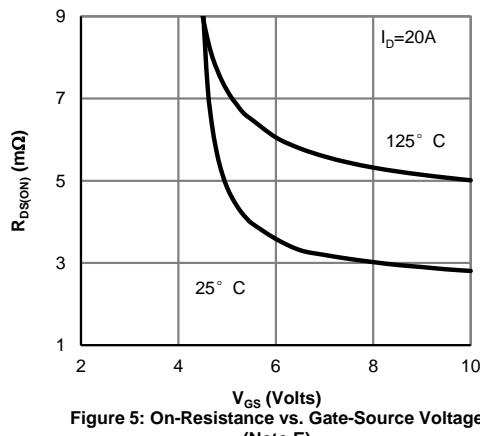
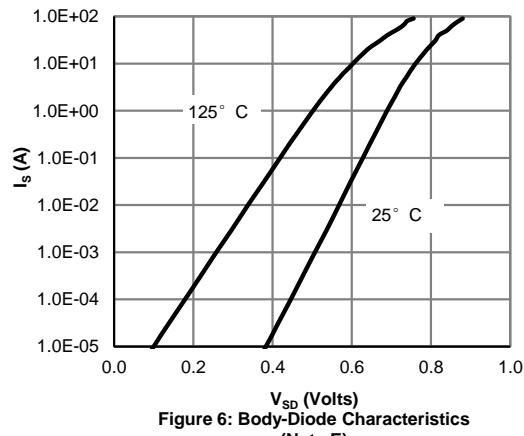
E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

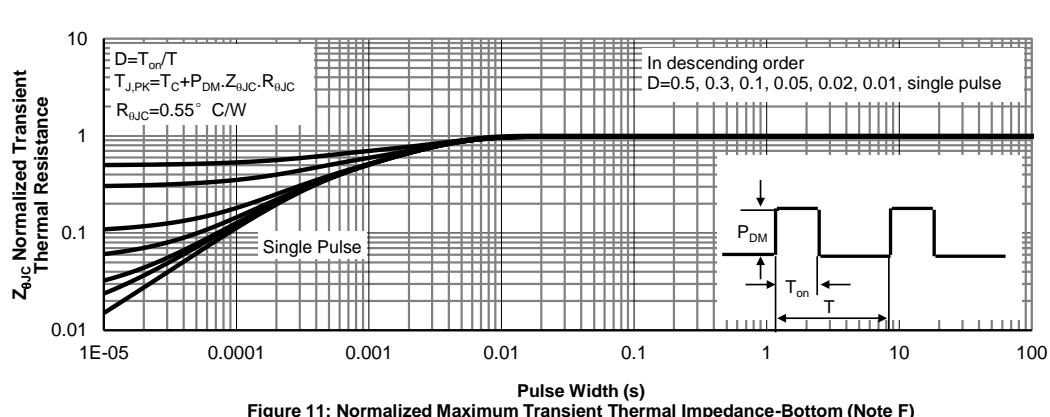
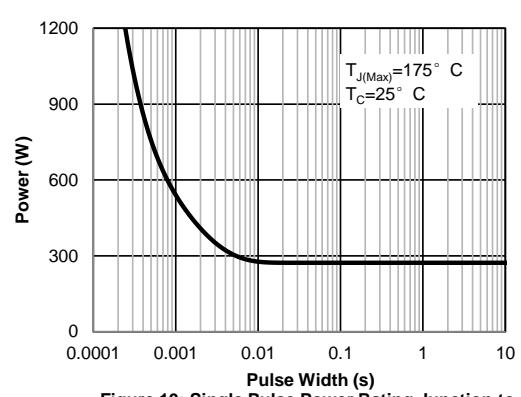
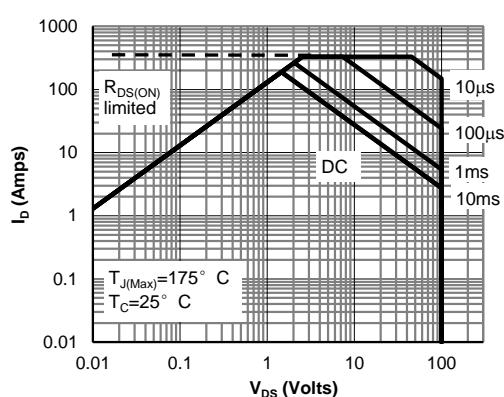
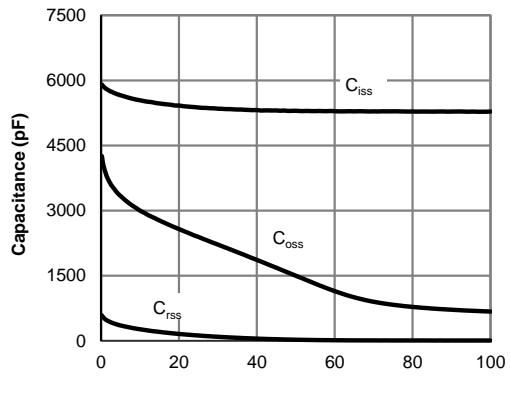
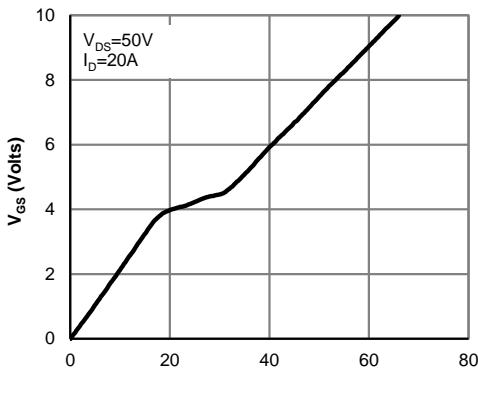
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=175^\circ\text{C}$. The SOA curve provides a single pulse rating.

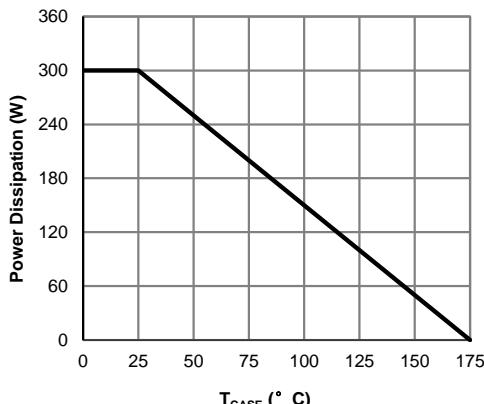
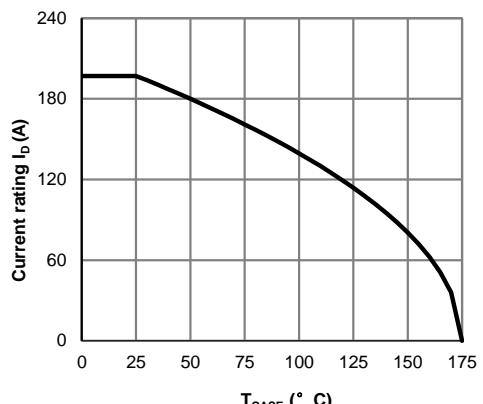
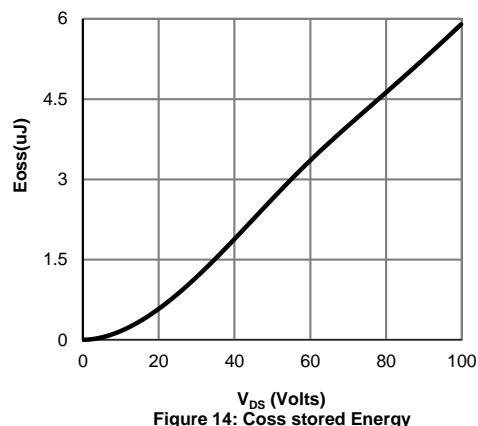
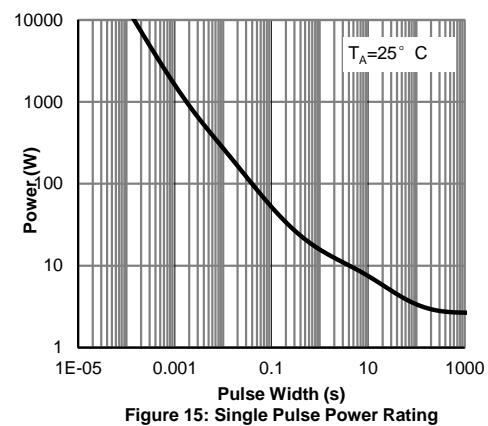
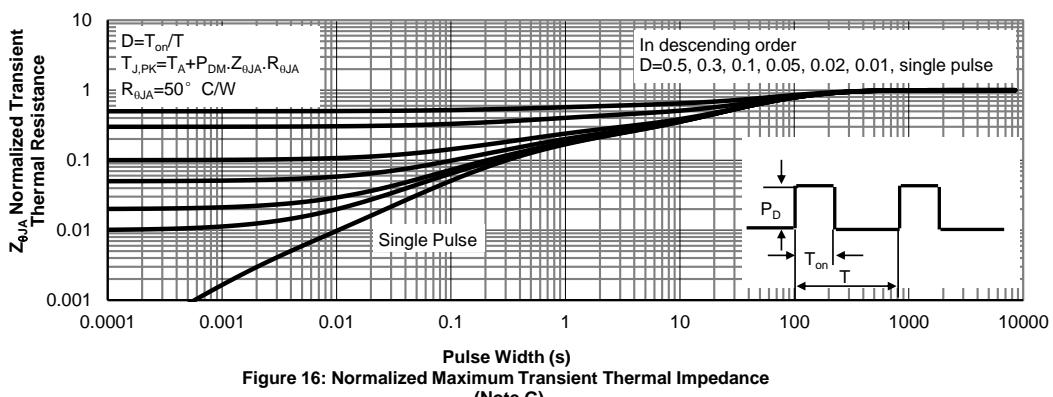
G. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1: On-Region Characteristics (Note E)

Figure 2: Transfer Characteristics (Note E)

Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

Figure 4: On-Resistance vs. Junction Temperature (Note E)

Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


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Figure 12: Power De-rating (Note F)

Figure 13: Current De-rating (Note F)

Figure 14: Coss stored Energy

**Figure 15: Single Pulse Power Rating
Junction-to-Ambient (Note G)**

**Figure 16: Normalized Maximum Transient Thermal Impedance
(Note G)**

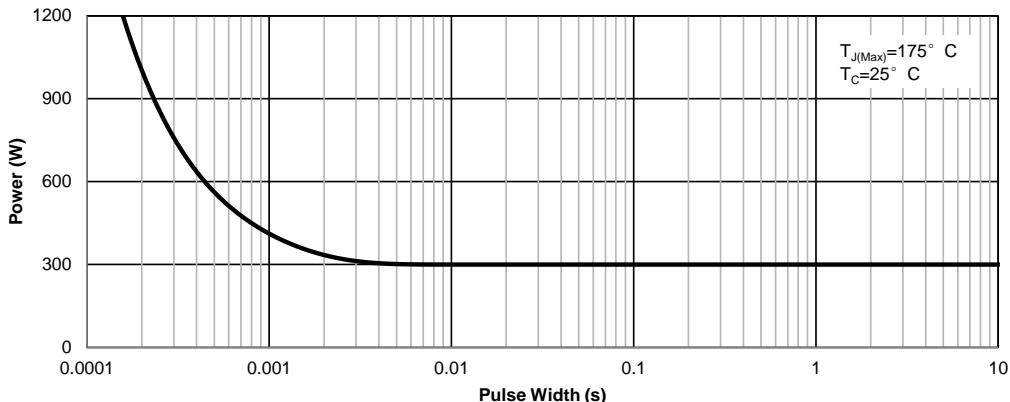
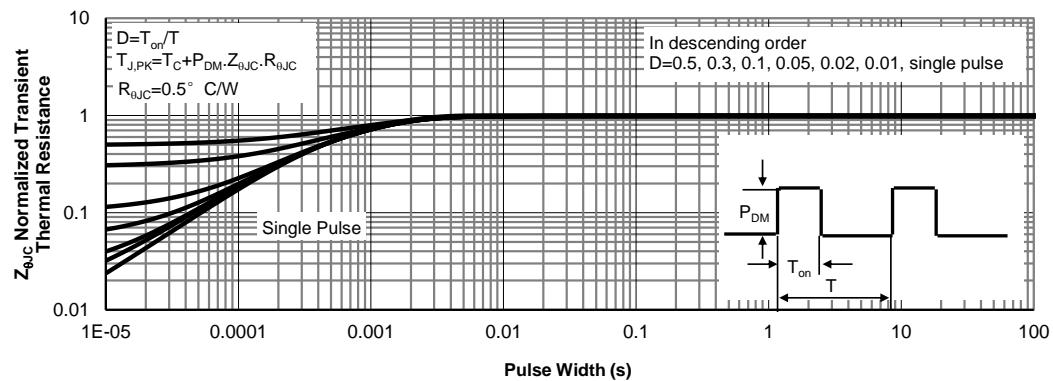
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 17: Single Pulse Power Rating Junction-to-Case-Top (Note F)

Figure 18: Normalized Maximum Transient Thermal Impedance-Top (Note F)

Figure A: Gate Charge Test Circuit & Waveforms

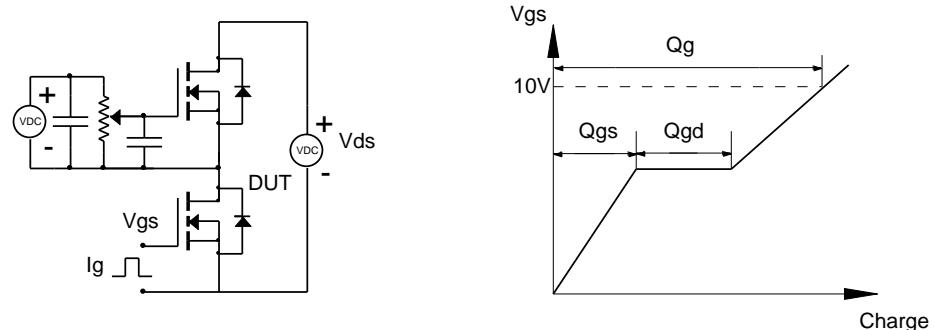


Figure B: Resistive Switching Test Circuit & Waveforms

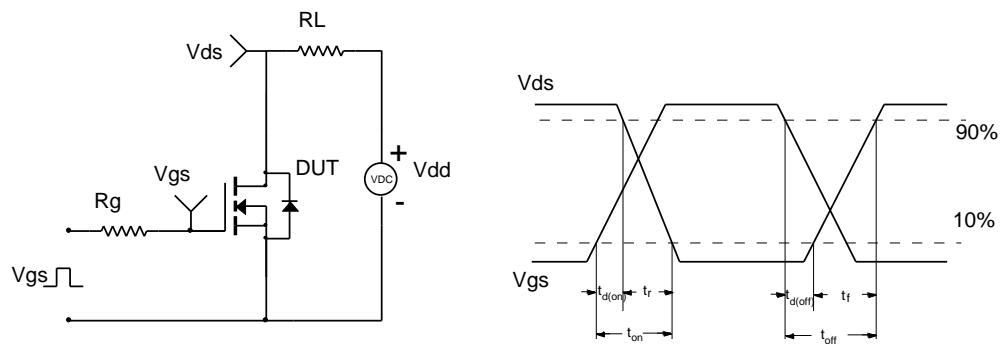


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

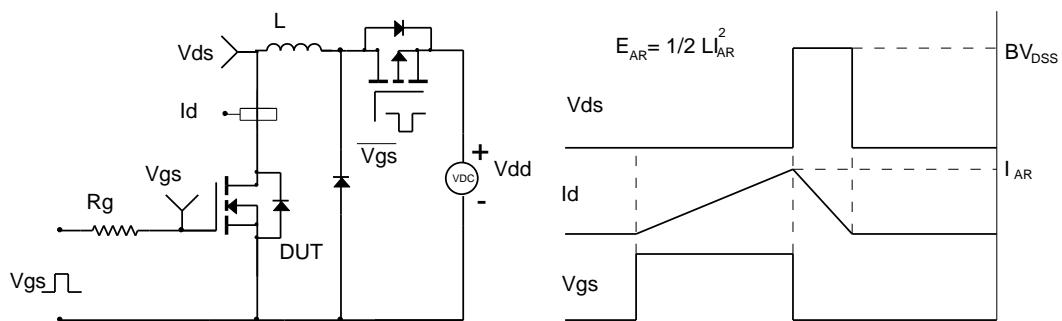


Figure D: Diode Recovery Test Circuit & Waveforms

